

Document Title

## 64Kx36-Bit Synchronous Burst SRAM

Revision History

| <u>Rev. No.</u> | <u>History</u>   | <u>Draft Date</u> | <u>Remark</u> |
|-----------------|--|-------------------|---------------|
| 0.0             | Initial draft  | July. 03. 1998    | Preliminary   |
| 0.1             | Change DC Characteristics.<br>Icc value from 320mA to 250mA at -7.<br>Icc value from 300mA to 230mA at -8.<br>Icc value from 280mA to 200mA at -9.<br>Iss value from 90mA to 70mA at -7.<br>Iss value from 80mA to 60mA at -8.<br>Iss value from 70mA to 50mA at -9.<br>Iss1 value from 30mA to 20mA<br>Iss2 value from 30mA to 20mA | Sep. 14. 1998     | Preliminary   |
| 1.0             | Final spec release.  | Nov. 16. 1998     | Final         |
| 2.0             | Add Vddo Supply voltage( 2.5V )  | Dec. 02. 1998     | Final         |
| 3.0             | Min t <sub>OH</sub> Parameter Change : from 2.0ns to 3.0ns<br>Min t <sub>LZC</sub> Parameter Change : from 0ns to 3ns  | Dec. 17. 1998     | Final         |

The attached data sheets are prepared and approved by SAMSUNG Electronics. SAMSUNG Electronics CO., LTD. reserve the right to change the specifications. SAMSUNG Electronics will evaluate and reply to your requests and questions on the parameters of this device. If you have any questions, please contact the SAMSUNG branch office near your office, call or contact Headquarters.



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## 64Kx36-Bit Synchronous Burst SRAM

### FEATURES

- Synchronous Operation.
- On-Chip Address Counter.
- Write Self-Timed Cycle.
- On-Chip Address and Control Registers.
- $V_{DD} = 3.3V + 0.3V / -0.165V$  Power Supply.
- $V_{DDO}$  Supply Voltage  $3.3V + 0.3V / -0.165V$  for  $3.3V$  I/O or  $2.5V + 0.4V / -0.125V$  for  $2.5V$  I/O.
- 5V Tolerant Inputs except I/O Pins.
- Byte Writable Function.
- Global Write Enable Controls a full bus-width write.
- Power Down State via ZZ Signal.
- Asynchronous Output Enable Control.
- ADSP, ADSC, ADV Burst Control Pins.
- LBO Pin allows a choice of either a interleaved burst or a linear burst.
- Three Chip Enables for simple depth expansion with No Data Contention.
- TTL-Level Three-State Output.
- 100-TQFP-1420A

### FAST ACCESS TIMES

| PARAMETER                 | Symbol | -7  | -8  | -9  | Unit |
|---------------------------|--------|-----|-----|-----|------|
| Cycle Time                | tcyc   | 8.5 | 10  | 12  | ns   |
| Clock Access Time         | tcd    | 7.5 | 8   | 9   | ns   |
| Output Enable Access Time | toe    | 3.5 | 3.5 | 3.5 | ns   |

### GENERAL DESCRIPTION

The KM736V687A is 2,359,296 bits Synchronous Static Random Access Memory designed to support zero wait state performance for advanced Pentium/Power PC based system. And with CS1 high, ADSP is blocked to control signals.

It can be organized as 64K words of 36 bits. And it integrates address and control registers, a 2-bit burst address counter and high output drive circuitry onto a single integrated circuit for reduced components counts implementation of high performance cache RAM applications.

Write cycles are internally self-timed and synchronous.

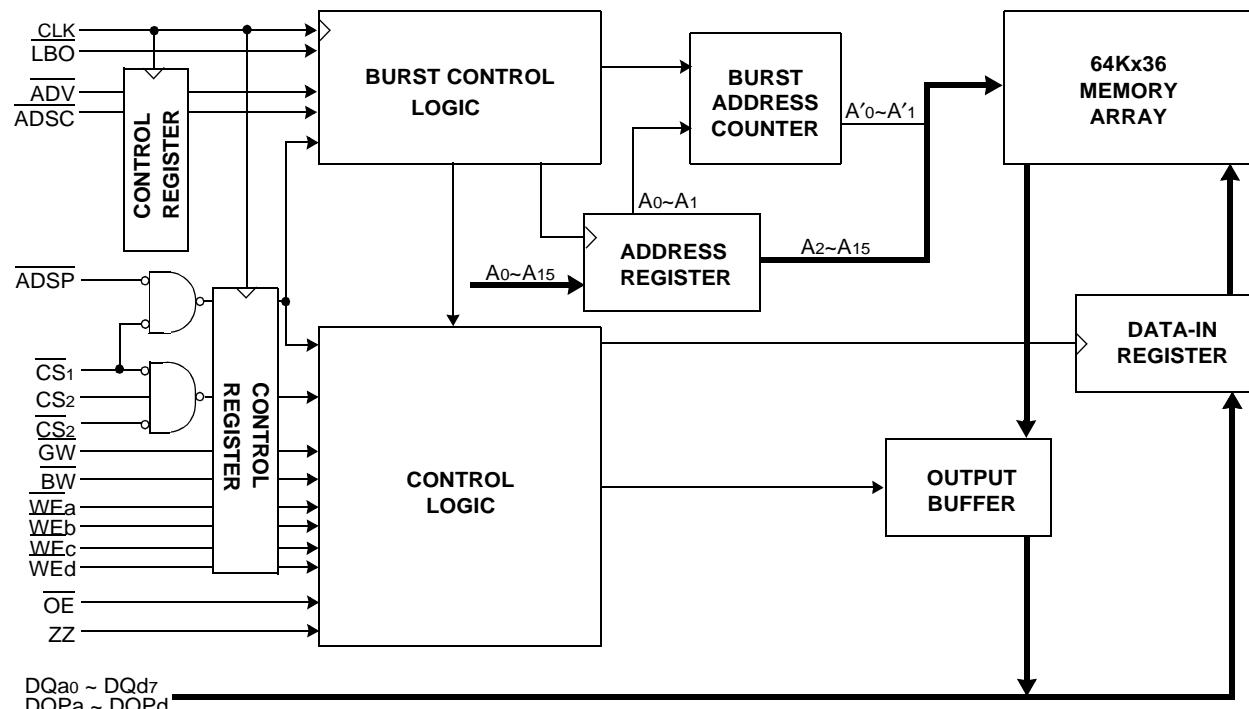
The self-timed write feature eliminates complex off chip write pulse shaping logic, simplifying the cache design and further reducing the component count.

Burst cycle can be initiated with either the address status processor(ADSP) or address status cache controller(ADSC) inputs. Subsequent burst addresses are generated internally in the system's burst sequence and are controlled by the burst address advance(ADV) input.

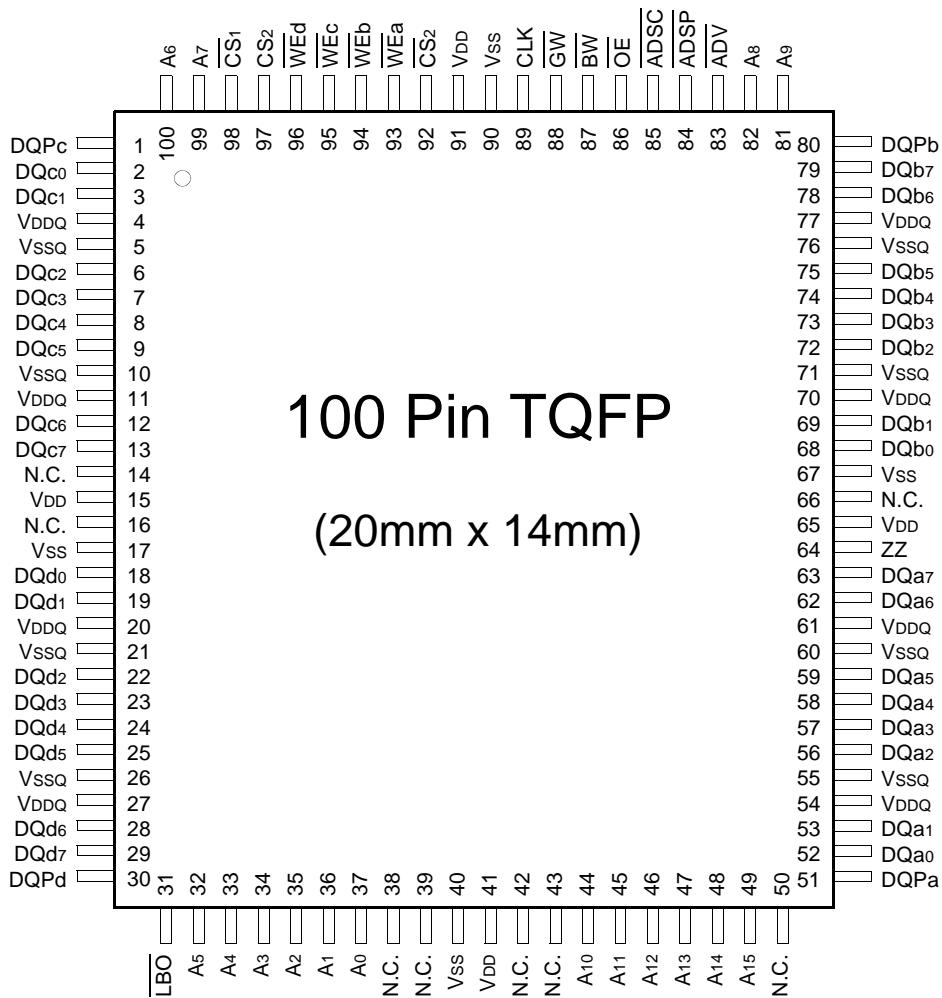
ZZ pin controls Power Down State and reduces Stand-by current regardless of CLK.

The KM736V687A is implemented with SAMSUNG's high performance CMOS technology and is available in a 100pin TQFP package. Multiple power and ground pins are utilized to minimize ground bounce.

### LOGIC BLOCK DIAGRAM



## PIN CONFIGURATION(TOP VIEW)



## PIN NAME

| SYMBOL                           | PIN NAME                  | TQFP PIN NO.   | SYMBOL                           | PIN NAME                              | TQFP PIN NO.                                       |
|----------------------------------|---------------------------|--|----------------------------------|---------------------------------------|--|
| A <sub>0</sub> - A <sub>15</sub> | Address Inputs            | 32,33,34,35,36,37,<br>44,45,46,47,48,49,<br>81,82,99,100 | V <sub>DD</sub>                  | Power Supply(+3.3V)                   | 15,41,65,91  |
| ADV                              | Burst Address Advance     | 83   | V <sub>ss</sub>                  | Ground                                | 17,40,67,90  |
| ADSP                             | Address Status Processor  | 84   | N.C.                             | No Connect                            | 14,16,38,39,42,43,50,66                            |
| ADSC                             | Address Status Controller | 85   | DQa <sub>0</sub> ~a <sub>7</sub> | Data Inputs/Outputs                   | 52,53,56,57,58,59,62,63<br>68,69,72,73,74,75,78,79 |
| CLK                              | Clock                     | 89   | DQb <sub>0</sub> ~b <sub>7</sub> |                                       | 2,3,6,7,8,9,12,13                                  |
| CS <sub>1</sub>                  | Chip Select               | 98   | DQc <sub>0</sub> ~c <sub>7</sub> |                                       | 18,19,22,23,24,25,28,29                            |
| CS <sub>2</sub>                  | Chip Select               | 97   | DQd <sub>0</sub> ~d <sub>7</sub> |                                       | 51,80,1,30   |
| CS <sub>2</sub>                  | Chip Select               | 92   | DQPa~Pd                          |                                       |  |
| WE <sub>x</sub>                  | Byte Write Inputs         | 93,94,95,96  | V <sub>DDQ</sub>                 | Output Power Supply<br>(2.5V or 3.3V) | 4,11,20,27,54,61,70,77                             |
| OE                               | Output Enable             | 86   | V <sub>ssq</sub>                 | Output Ground                         | 5,10,21,26,55,60,71,76                             |
| GW                               | Global Write Enable       | 88   |                                  |                                       |  |
| BW                               | Byte Write Enable         | 87   |                                  |                                       |  |
| ZZ                               | Power Down Input          | 64   |                                  |                                       |  |
| LBO                              | Burst Mode Control        | 31   |                                  |                                       |  |

## FUNCTION DESCRIPTION

The KM736V687A is a synchronous SRAM designed to support the burst address accessing sequence of the Pentium and Power PC based microprocessor. All inputs (with the exception of OE, LBO and ZZ) are sampled on rising clock edges. The start and duration of the burst access is controlled by ADSC, ADSP and ADV and chip select pins.

When ZZ is pulled high, the SRAM will enter a Power Down State. At this time, internal state of the SRAM is preserved. When ZZ returns to low, the SRAM normally operates after 2cycles of wake up time. ZZ pin is pulled down internally.

Read cycles are initiated with ADSP(or ADSC) using the new external address clocked into the on-chip address register when both GW and BW are high or when BW is low and WEa, WEb, WEc, and WEd are high. When ADSP is sampled low, the chip selects are sampled active, and the output buffer is enabled with OE. the data of cell array accessed by the current address are projected to the output pins.

Write cycles are also initiated with ADSP(or ADSC) and are differentiated into two kinds of operations; All byte write operation and individual byte write operation.

All byte write occurs by enabling GW(independent of BW and WEx), and individual byte write is performed only when GW is high and BW is low. In KM736V687A, a 64Kx36 organization, WEa controls DQa0 ~ DQa7 and DQPa, WEb controls DQb0 ~ DQb7 and DQNb, WEc controls DQc0 ~ DQc7 and DQFc and WEd controls DQd0 ~ DQd7 and DQFd.

CS1 is used to enable the device and conditions internal use of ADSP and is sampled only when a new external address is loaded.

ADV is ignored at the clock edge when ADSP is asserted, but can be sampled on the subsequent clock edges. The address increases internally for the next access of the burst when ADV is sampled low.

Addresses are generated for the burst access as shown below, The starting point of the burst sequence is provided by the external address. The burst address counter wraps around to its initial state upon completion. The burst sequence is determined by the state of the LBO pin. When this pin is Low, linear burst sequence is selected. And this pin is High, Interleaved burst sequence is selected.

## BURST SEQUENCE TABLE

(Interleaved Burst)

| <u>LBO</u> PIN     | HIGH | Case 1    |           | Case 2    |           | Case 3    |           | Case 4    |           |
|--------------------|------|-----------|-----------|-----------|-----------|-----------|-----------|-----------|-----------|
|                    |      | <u>A1</u> | <u>A0</u> | <u>A1</u> | <u>A0</u> | <u>A1</u> | <u>A0</u> | <u>A1</u> | <u>A0</u> |
| First Address<br>↓ | 0    | 0         | 0         | 1         | 1         | 0         | 1         | 1         | 1         |
|                    | 0    | 1         | 0         | 0         | 1         | 1         | 1         | 1         | 0         |
|                    | 1    | 0         | 1         | 1         | 0         | 0         | 0         | 0         | 1         |
| Fourth Address     | 1    | 1         | 1         | 0         | 0         | 1         | 0         | 0         | 0         |

(Linear Burst)

| <u>LBO</u> PIN     | LOW | Case 1    |           | Case 2    |           | Case 3    |           | Case 4    |           |
|--------------------|-----|-----------|-----------|-----------|-----------|-----------|-----------|-----------|-----------|
|                    |     | <u>A1</u> | <u>A0</u> | <u>A1</u> | <u>A0</u> | <u>A1</u> | <u>A0</u> | <u>A1</u> | <u>A0</u> |
| First Address<br>↓ | 0   | 0         | 0         | 1         | 1         | 0         | 1         | 1         | 1         |
|                    | 0   | 1         | 1         | 0         | 1         | 1         | 0         | 0         | 0         |
|                    | 1   | 0         | 1         | 1         | 0         | 0         | 0         | 0         | 1         |
| Fourth Address     | 1   | 1         | 0         | 0         | 0         | 1         | 1         | 1         | 0         |

Note : 1. LBO pin must be tied to high or low, and floating state must not be allowed.

## ASYNCHRONOUS TRUTH TABLE

(See Notes 1 and 2):

| OPERATION  | <u>ZZ</u> | <u>OE</u> | I/O STATUS  |
|------------|-----------|-----------|-------------|
| Sleep Mode | H         | X         | High-Z      |
| Read       | L         | L         | DQ          |
|            | L         | H         | High-Z      |
| Write      | L         | X         | Din, High-Z |
| Deselected | L         | X         | High-Z      |

### Notes

1. X means "Don't Care".
2. ZZ pin is pulled down internally
3. For write cycles that following read cycles, the output buffers must be disabled with OE, otherwise data bus contention will occur.
4. Sleep Mode means power down state of which stand-by current does not depend on cycle time.
5. Deselected means power down state of which stand-by current depends on cycle time.



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**SYNCHRONOUS TRUTH TABLE**

| <u>CS<sub>1</sub></u> | CS <sub>2</sub> | <u>CS<sub>2</sub></u> | <u>ADSP</u> | <u>ADS</u> | <u>ADV</u> | <u>WRITE</u> | CLK | ADDRESS ACCESSED | Operation                  |
|-----------------------|-----------------|-----------------------|-------------|------------|------------|--------------|-----|------------------|----------------------------|
| H                     | X               | X                     | X           | L          | X          | X            | ↑   | N/A              | Not Selected               |
| L                     | L               | X                     | L           | X          | X          | X            | ↑   | N/A              | Not Selected               |
| L                     | X               | H                     | L           | X          | X          | X            | ↑   | N/A              | Not Selected               |
| L                     | L               | X                     | X           | L          | X          | X            | ↑   | N/A              | Not Selected               |
| L                     | X               | H                     | X           | L          | X          | X            | ↑   | N/A              | Not Selected               |
| L                     | H               | L                     | L           | X          | X          | X            | ↑   | External Address | Begin Burst Read Cycle     |
| L                     | H               | L                     | H           | L          | X          | L            | ↑   | External Address | Begin Burst Write Cycle    |
| L                     | H               | L                     | H           | L          | X          | H            | ↑   | External Address | Begin Burst Read Cycle     |
| X                     | X               | X                     | H           | H          | L          | H            | ↑   | Next Address     | Continue Burst Read Cycle  |
| H                     | X               | X                     | X           | H          | L          | H            | ↑   | Next Address     | Continue Burst Read Cycle  |
| X                     | X               | X                     | H           | H          | L          | L            | ↑   | Next Address     | Continue Burst Write Cycle |
| H                     | X               | X                     | X           | H          | L          | L            | ↑   | Next Address     | Continue Burst Write Cycle |
| X                     | X               | X                     | H           | H          | H          | H            | ↑   | Current Address  | Suspend Burst Read Cycle   |
| H                     | X               | X                     | X           | H          | H          | H            | ↑   | Current Address  | Suspend Burst Read Cycle   |
| X                     | X               | X                     | H           | H          | H          | L            | ↑   | Current Address  | Suspend Burst Write Cycle  |
| H                     | X               | X                     | X           | H          | H          | L            | ↑   | Current Address  | Suspend Burst Write Cycle  |

**Notes :** 1. X means "Don't Care".

2. The rising edge of clock is symbolized by ↑.

3. WRITE = L means Write operation in WRITE TRUTH TABLE.

WRITE = H means Read operation in WRITE TRUTH TABLE.

4. Operation finally depends on status of asynchronous input pins(ZZ and OE).

**WRITE TRUTH TABLE**

| <u>GW</u> | <u>BW</u> | <u>WE<sub>a</sub></u> | <u>WE<sub>b</sub></u> | <u>WE<sub>c</sub></u> | <u>WE<sub>d</sub></u> | OPERATION          |
|-----------|-----------|-----------------------|-----------------------|-----------------------|-----------------------|--------------------|
| H         | H         | X                     | X                     | X                     | X                     | READ               |
| H         | L         | H                     | H                     | H                     | H                     | READ               |
| H         | L         | L                     | H                     | H                     | H                     | WRITE BYTE a       |
| H         | L         | H                     | L                     | H                     | H                     | WRITE BYTE b       |
| H         | L         | H                     | H                     | L                     | L                     | WRITE BYTE c and d |
| H         | L         | L                     | L                     | L                     | L                     | WRITE ALL BYTES    |
| L         | X         | X                     | X                     | X                     | X                     | WRITE ALL BYTES    |

**Notes :** 1. X means "Don't Care".

2. All inputs in this table must meet setup and hold time around the rising edge of CLK(↑).



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**ABSOLUTE MAXIMUM RATINGS\***

| PARAMETER                              | SYMBOL | RATING             | UNIT |
|--|--------|--------------------|------|
| Voltage on VDD Supply Relative to Vss  | VDD    | -0.3 to 4.6        | V    |
| Voltage on VDDQ Supply Relative to Vss | VDDQ   | VDD                | V    |
| Voltage on Input Pin Relative to Vss   | VIN    | -0.3 to 6.0        | V    |
| Voltage on I/O Pin Relative to Vss     | VIO    | -0.3 to VDDQ + 0.5 | V    |
| Power Dissipation                      | PD     | 1.2                | W    |
| Storage Temperature                    | TSTG   | -65 to 150         | °C   |
| Operating Temperature                  | TOPR   | 0 to 70            | °C   |
| Storage Temperature Range Under Bias   | TBIAS  | -10 to 85          | °C   |

\*Notes : Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

**OPERATING CONDITIONS at 3.3V I/O ( $0^{\circ}\text{C} \leq \text{TA} \leq 70^{\circ}\text{C}$ )**

| PARAMETER      | SYMBOL | MIN   | Typ. | MAX | UNIT |
|----------------|--------|-------|------|-----|------|
| Supply Voltage | VDD    | 3.135 | 3.3  | 3.6 | V    |
|                | VDDQ   | 3.135 | 3.3  | 3.6 | V    |
| Ground         | VSS    | 0     | 0    | 0   | V    |

**OPERATING CONDITIONS at 2.5V I/O ( $0^{\circ}\text{C} \leq \text{TA} \leq 70^{\circ}\text{C}$ )**

| PARAMETER      | SYMBOL | MIN   | Typ. | MAX | UNIT |
|----------------|--------|-------|------|-----|------|
| Supply Voltage | VDD    | 3.135 | 3.3  | 3.6 | V    |
|                | VDDQ   | 2.375 | 2.5  | 2.9 | V    |
| Ground         | VSS    | 0     | 0    | 0   | V    |

**CAPACITANCE\* ( $\text{TA}=25^{\circ}\text{C}$ ,  $f=1\text{MHz}$ )**

| PARAMETER          | SYMBOL | TEST CONDITION | MIN | MAX | UNIT |
|--------------------|--------|----------------|-----|-----|------|
| Input Capacitance  | CIN    | VIN=0V         | -   | 5   | pF   |
| Output Capacitance | COUT   | VOUT=0V        | -   | 7   | pF   |

\*Note : Sampled not 100% tested.



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**DC ELECTRICAL CHARACTERISTICS**( $T_A=0$  to  $70^\circ\text{C}$ ,  $V_{DD}=3.3\text{V}+0.3\text{V}/-0.165\text{V}$ )

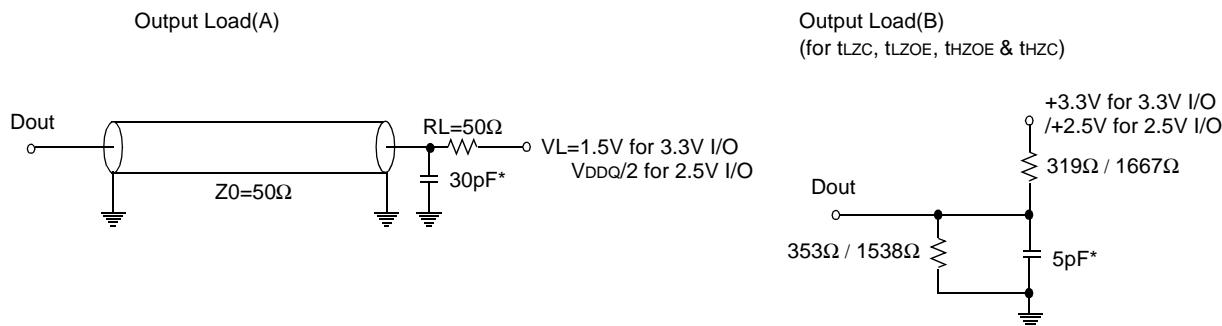
| PARAMETER                        | SYMBOL    | TEST CONDITIONS  | MIN   | MAX               | UNIT          |
|----------------------------------|-----------|--|-------|-------------------|---------------|
| Input Leakage Current(except ZZ) | $I_{IL}$  | $V_{DD}=\text{Max}$ , $V_{IN}=V_{SS}$ to $V_{DD}$  | -2    | +2                | $\mu\text{A}$ |
| Output Leakage Current           | $I_{OL}$  | Output Disabled, $V_{OUT}=V_{SS}$ to $V_{DDQ}$   | -2    | +2                | $\mu\text{A}$ |
| Operating Current                | $I_{CC}$  | Device Selected, $I_{OUT}=0\text{mA}$ ,<br>$ZZ \leq V_{IL}$ , All Inputs= $V_{IL}$ or $V_{IH}$<br>Cycle Time $\geq t_{CYC}$ min                | -7    | -                 | 250           |
|                                  |           |  | -8    | -                 | 230           |
|                                  |           |  | -9    | -                 | 200           |
| Standby Current                  | $I_{SB}$  | Device deselected, $I_{OUT}=0\text{mA}$ ,<br>$ZZ \leq V_{IL}$ , $f=\text{Max}$ ,<br>All Inputs $\leq 0.2\text{V}$ or $\geq V_{DD}-0.2\text{V}$ | -7    | -                 | 70            |
|                                  |           |  | -8    | -                 | 60            |
|                                  |           |  | -9    | -                 | 50            |
| Standby Current                  | $I_{SB1}$ | Device deselected, $I_{OUT}=0\text{mA}$ , $ZZ \leq 0.2\text{V}$ ,<br>$f=0$ , All Inputs=fixed ( $V_{DD}-0.2\text{V}$ or $0.2\text{V}$ )        | -     | 20                | $\text{mA}$   |
|                                  | $I_{SB2}$ | Device deselected, $I_{OUT}=0\text{mA}$ , $ZZ \geq V_{DD}-0.2\text{V}$ ,<br>$f=\text{Max}$ , All Inputs $\leq V_{IL}$ or $\geq V_{IH}$         | -     | 20                | $\text{mA}$   |
| Output Low Voltage(3.3V I/O)     | $V_{OL}$  | $I_{OL} = 8.0\text{mA}$  | -     | 0.4               | $\text{V}$    |
| Output High Voltage(3.3V I/O)    | $V_{OH}$  | $I_{OH} = -4.0\text{mA}$   | 2.4   | -                 | $\text{V}$    |
| Output Low Voltage(2.5V I/O)     | $V_{OL}$  | $I_{OL} = 1.0\text{mA}$  | -     | 0.4               | $\text{V}$    |
| Output High Voltage(2.5V I/O)    | $V_{OH}$  | $I_{OH} = -1.0\text{mA}$   | 2.0   | -                 | $\text{V}$    |
| Input Low Voltage(3.3V I/O)      | $V_{IL}$  |  | -0.5* | 0.8               | $\text{V}$    |
| Input High Voltage(3.3V I/O)     | $V_{IH}$  |  | 2.0   | $V_{DD}+0.5^{**}$ | $\text{V}$    |
| Input Low Voltage(2.5V I/O)      | $V_{IL}$  |  | -0.3* | 0.7               | $\text{V}$    |
| Input High Voltage(2.5V I/O)     | $V_{IH}$  |  | 1.7   | $V_{DD}+0.5^{**}$ | $\text{V}$    |

\*  $V_{IL}(\text{Min})=-2.0$ (Pulse Width  $\leq t_{CYC}/2$ )\*\*  $V_{IH}(\text{Max})=4.6$ (Pulse Width  $\leq t_{CYC}/2$ )\*\* In Case of I/O Pins, the Max.  $V_{IH}=V_{DDQ}+0.5\text{V}$ **TEST CONDITIONS** $(V_{DD}=3.3\text{V}+0.3\text{V}/-0.165\text{V}, V_{DDQ}=3.3\text{V}+0.3\text{V}/-0.165\text{V}$  or  $V_{DD}=3.3\text{V}+0.3\text{V}/-0.165\text{V}, V_{DDQ}=2.5\text{V}+0.4\text{V}/-0.125\text{V}$ ,  $T_A=0$  to  $70^\circ\text{C}$ )

| PARAMETER  | VALUE       |
|--|-------------|
| Input Pulse Level(for 3.3V I/O)                                  | 0 to 3V     |
| Input Pulse Level(for 2.5V I/O)                                  | 0 to 2.5V   |
| Input Rise and Fall Time(Measured at 0.3V and 2.7V for 3.3V I/O) | 1ns         |
| Input Rise and Fall Time(Measured at 0.3V and 2.1V for 2.5V I/O) | 1ns         |
| Input and Output Timing Reference Levels for 3.3V I/O            | 1.5V        |
| Input and Output Timing Reference Levels for 2.5V I/O            | $V_{DDQ}/2$ |
| Output Load  | See Fig. 1  |



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\* Capacitive Load consists of all components of the test environment.

\* Including Scope and Jig Capacitance

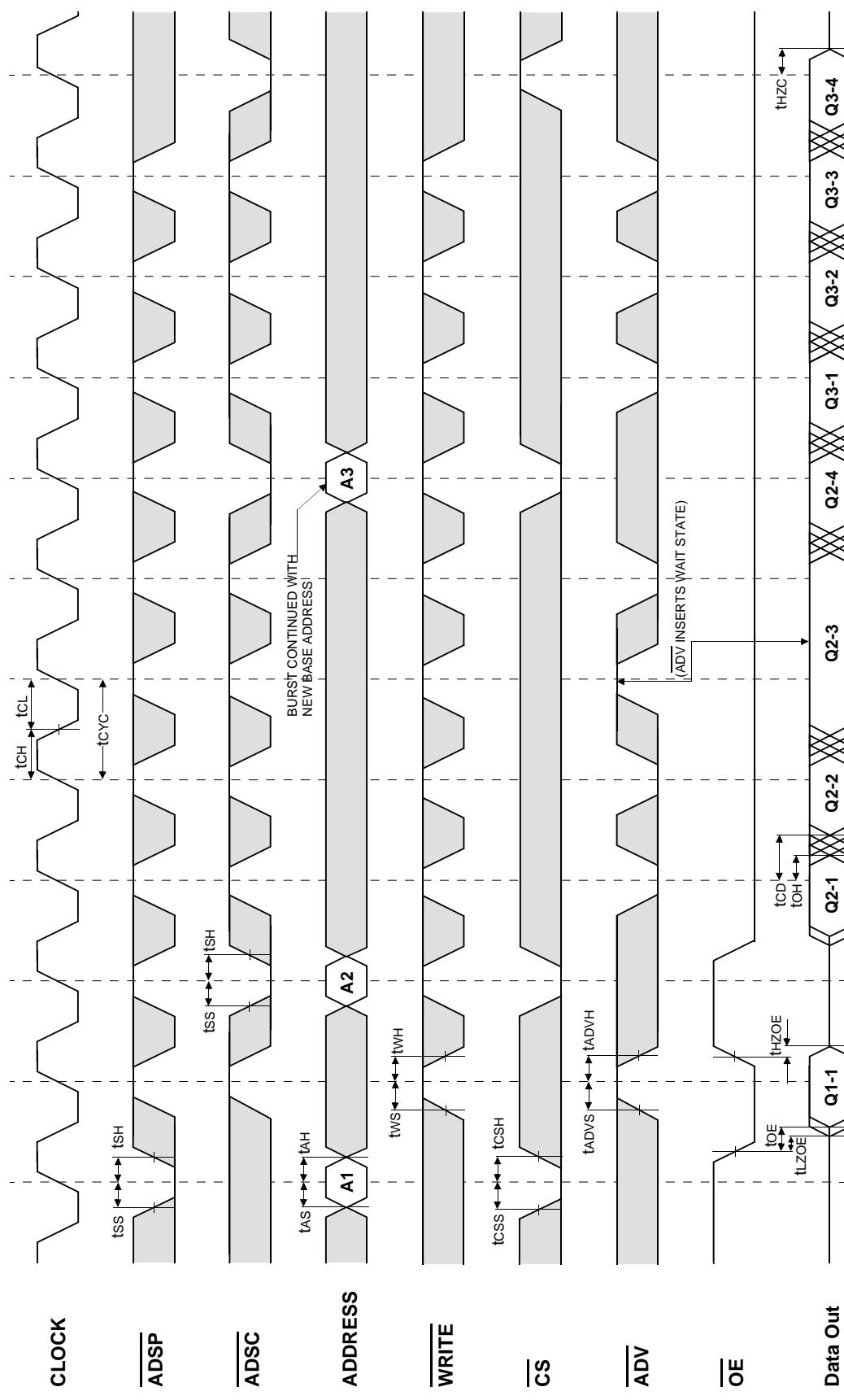
Fig. 1

### AC TIMING CHARACTERISTICS ( $T_A=0$ to $70^\circ\text{C}$ , $V_{DD}=3.3\text{V}+0.3\text{V}/-0.165\text{V}$ )

| PARAMETER   | SYMBOL | KM736V687A-7 |     | KM736V687A-8 |     | KM736V687A-9 |     | UNIT  |
|---|--------|--------------|-----|--------------|-----|--------------|-----|-------|
|   |        | MIN          | MAX | MIN          | MAX | MIN          | MAX |       |
| Cycle Time  | tCYC   | 8.5          | -   | 10           | -   | 12           | -   | ns    |
| Clock Access Time   | tCD    | -            | 7.5 | -            | 8   | -            | 9   | ns    |
| Output Enable to Data Valid   | toE    | -            | 3.5 | -            | 3.5 | -            | 3.5 | ns    |
| Clock High to Output Low-Z  | tLZC   | 3            | -   | 3            | -   | 3            | -   | ns    |
| Output Hold from Clock High   | toH    | 3            | -   | 3            | -   | 3            | -   | ns    |
| Output Enable Low to Output Low-Z   | tLZOE  | 0            | -   | 0            | -   | 0            | -   | ns    |
| Output Enable High to Output High-Z   | tHZOE  | -            | 3.5 | -            | 3.5 | -            | 3.5 | ns    |
| Clock High to Output High-Z   | tHZC   | 2            | 3.5 | 2            | 3.5 | 2            | 3.5 | ns    |
| Clock High Pulse Width  | tCH    | 3            | -   | 4            | -   | 4.5          | -   | ns    |
| Clock Low Pulse Width   | tCL    | 3            | -   | 4            | -   | 4.5          | -   | ns    |
| Address Setup to Clock High   | tas    | 2.0          | -   | 2.0          | -   | 2.0          | -   | ns    |
| Address Status Setup to Clock High  | tss    | 2.0          | -   | 2.0          | -   | 2.0          | -   | ns    |
| Data Setup to Clock High  | tDS    | 2.0          | -   | 2.0          | -   | 2.0          | -   | ns    |
| Write Setup to Clock High( $\overline{GW}$ , $\overline{BW}$ , $\overline{WE_x}$ )  | tws    | 2.0          | -   | 2.0          | -   | 2.0          | -   | ns    |
| Address Advance Setup to Clock High   | tADVS  | 2.0          | -   | 2.0          | -   | 2.0          | -   | ns    |
| Chip Select Setup to Clock High   | tcSS   | 2.0          | -   | 2.0          | -   | 2.0          | -   | ns    |
| Address Hold from Clock High  | tAH    | 0.5          | -   | 0.5          | -   | 0.5          | -   | ns    |
| Address Status Hold from Clock High   | tSH    | 0.5          | -   | 0.5          | -   | 0.5          | -   | ns    |
| Data Hold from Clock High   | tdH    | 0.5          | -   | 0.5          | -   | 0.5          | -   | ns    |
| Write Hold from Clock High( $\overline{GW}$ , $\overline{BW}$ , $\overline{WE_x}$ ) | tWH    | 0.5          | -   | 0.5          | -   | 0.5          | -   | ns    |
| Address Advance Hold from Clock High  | tADVH  | 0.5          | -   | 0.5          | -   | 0.5          | -   | ns    |
| Chip Select Hold from Clock High  | tCSH   | 0.5          | -   | 0.5          | -   | 0.5          | -   | ns    |
| ZZ High to Power Down   | tPDS   | 2            | -   | 2            | -   | 2            | -   | cycle |
| ZZ Low to Power Up  | tPUS   | 2            | -   | 2            | -   | 2            | -   | cycle |

- Notes :**
1. All address inputs must meet the specified setup and hold times for all rising clock edges whenever ADSC and/or ADSP is sampled low and CS is sampled low. All other synchronous inputs must meet the specified setup and hold times whenever this device is chip selected.
  2. Both chip selects must be active whenever ADSC or ADSP is sampled low in order for the this device to remain enabled.
  3. ADSC or ADSP must not be asserted for at least 2 Clock after leaving ZZ state.
  4. At any given voltage and temperature, tHZC is less than tLZC.

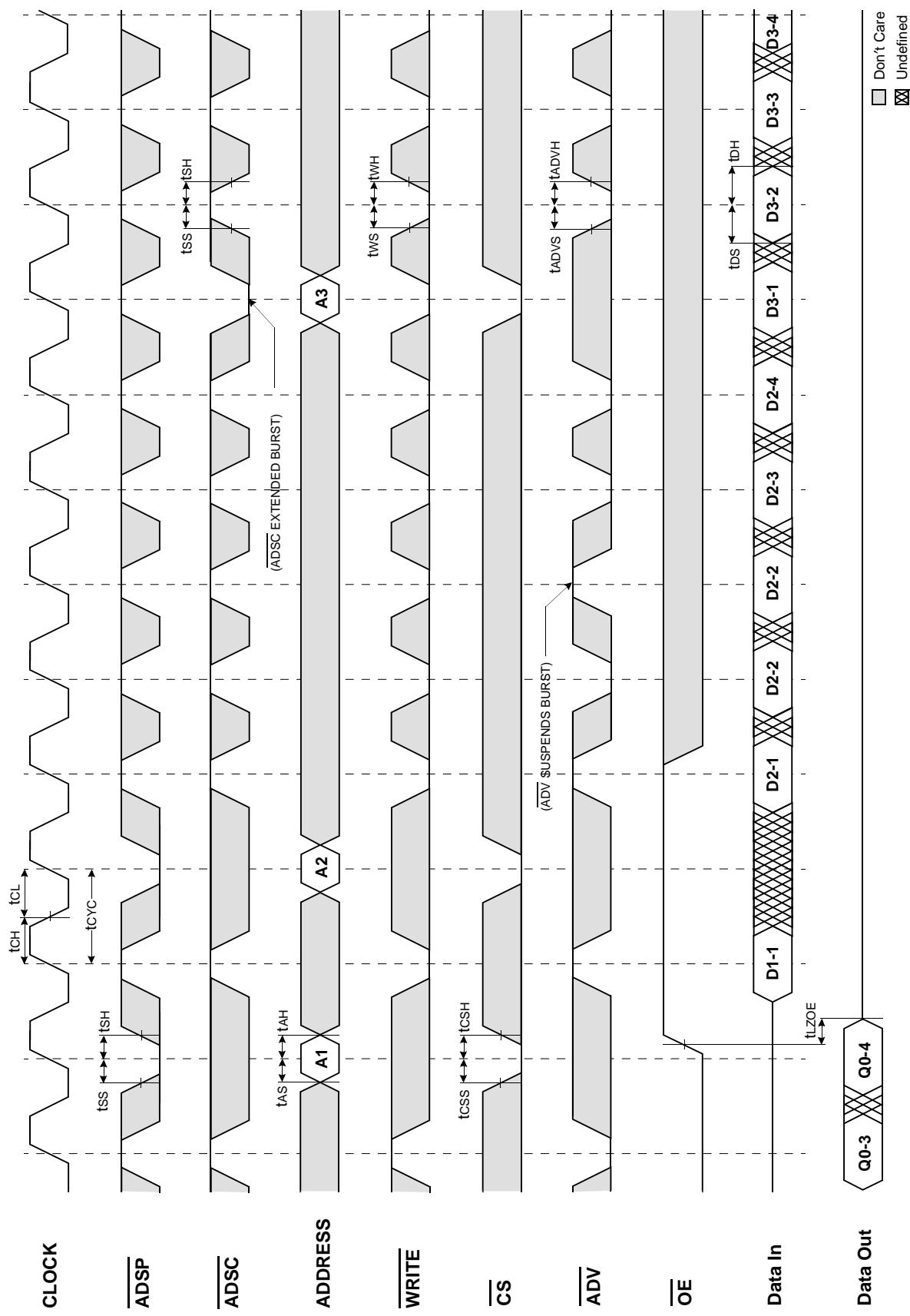
## TIMING WAVEFORM OF READ CYCLE

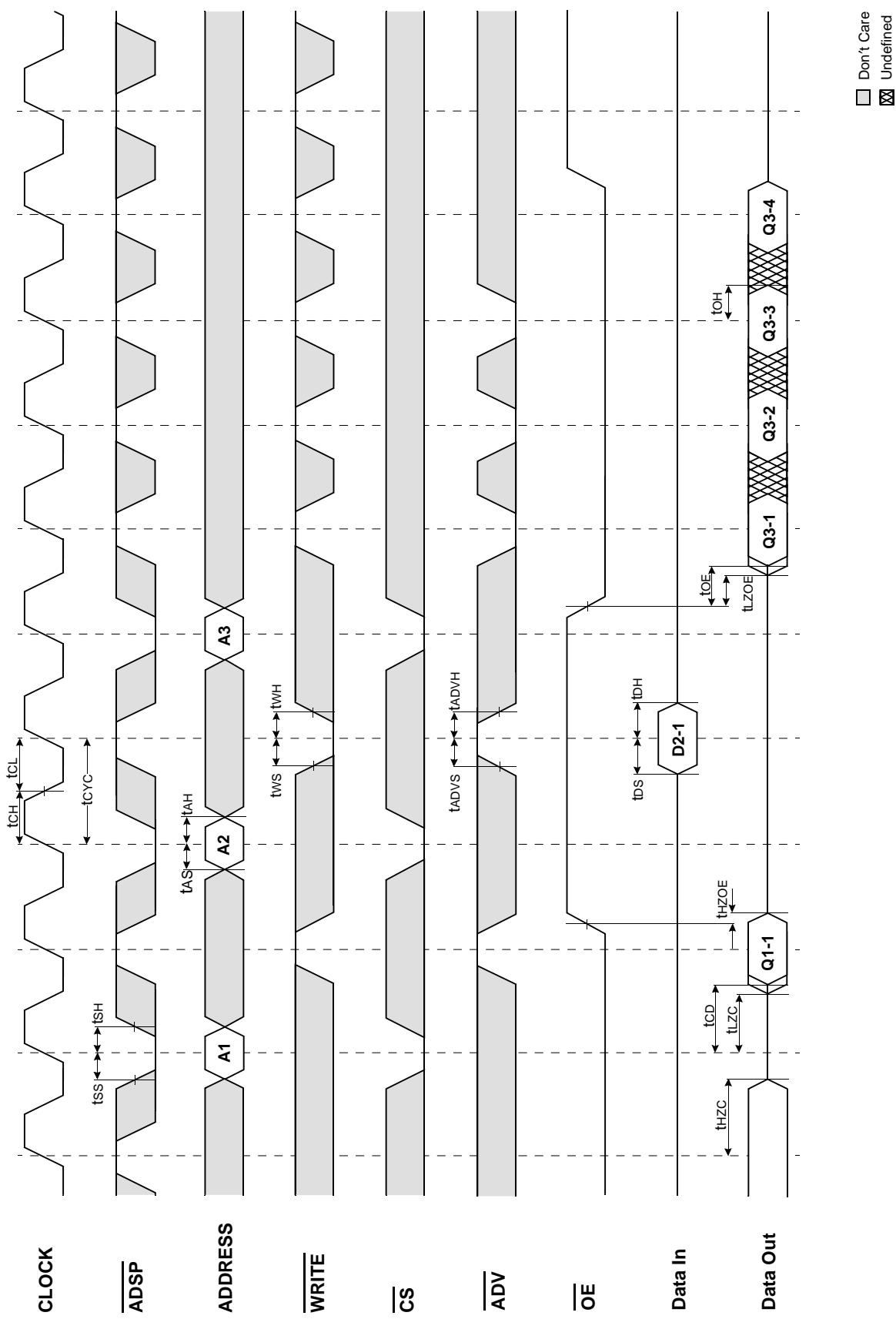


□ Don't Care  
☒ Undefined

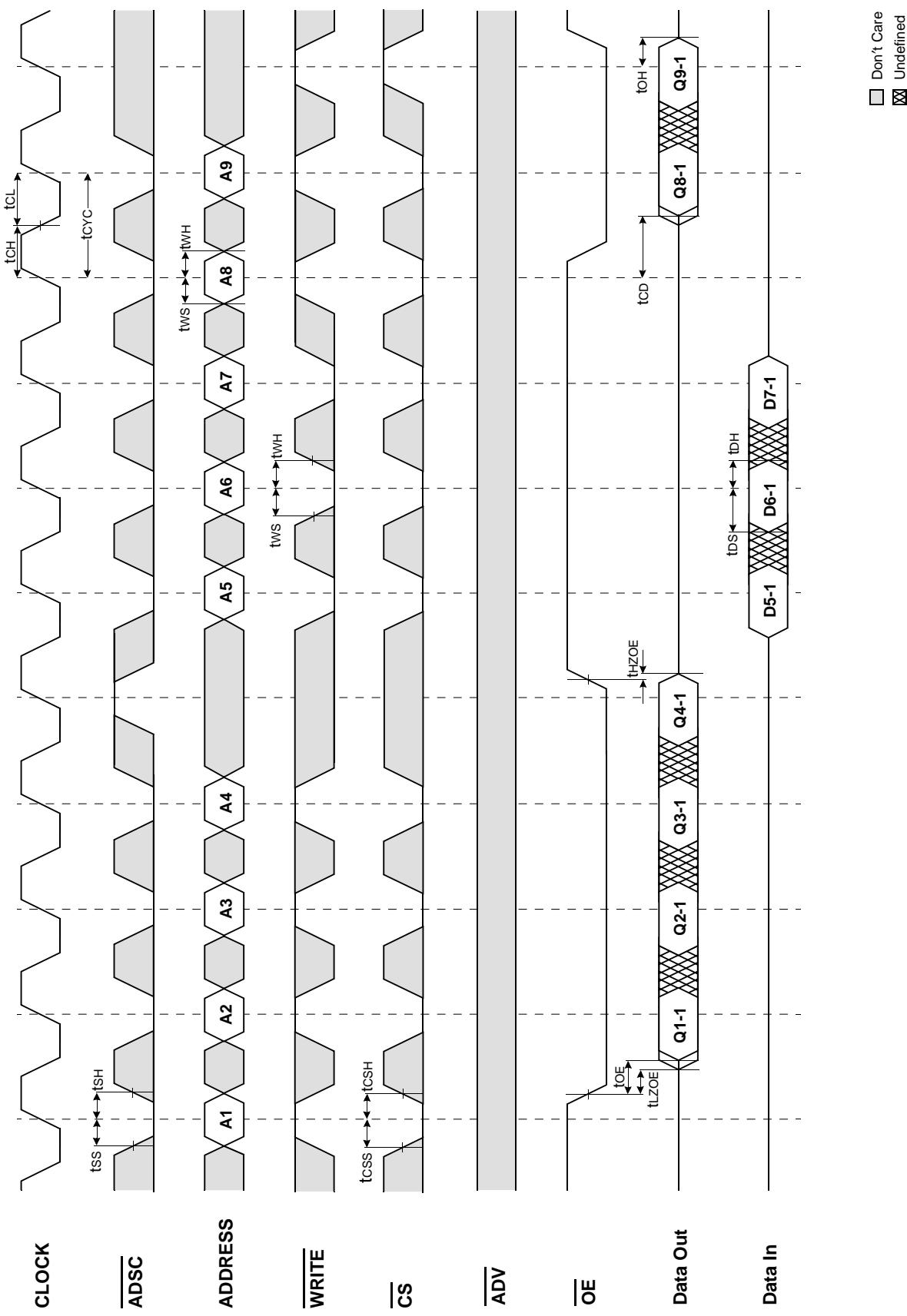
NOTES :  $\overline{\text{WRITE}} = \text{L}$  means  $\overline{\text{GW}} = \text{L}$ , or  $\overline{\text{GW}} = \text{H}$ ,  $\overline{\text{BW}} = \text{L}$ ,  $\overline{\text{WE}} = \text{L}$   
 $\overline{\text{CS}} = \text{L}$  means  $\overline{\text{CS}_1} = \text{L}$ ,  $\text{CS}_2 = \text{H}$  and  $\overline{\text{CS}_2} = \text{L}$   
 $\overline{\text{CS}} = \text{H}$  means  $\overline{\text{CS}_1} = \text{H}$ , or  $\overline{\text{CS}_1} = \text{L}$  and  $\overline{\text{CS}_2} = \text{H}$ , or  $\overline{\text{CS}_1} = \text{L}$ , and  $\overline{\text{CS}_2} = \text{L}$

## TIMING WAVEFORM OF WRITE CYCLE

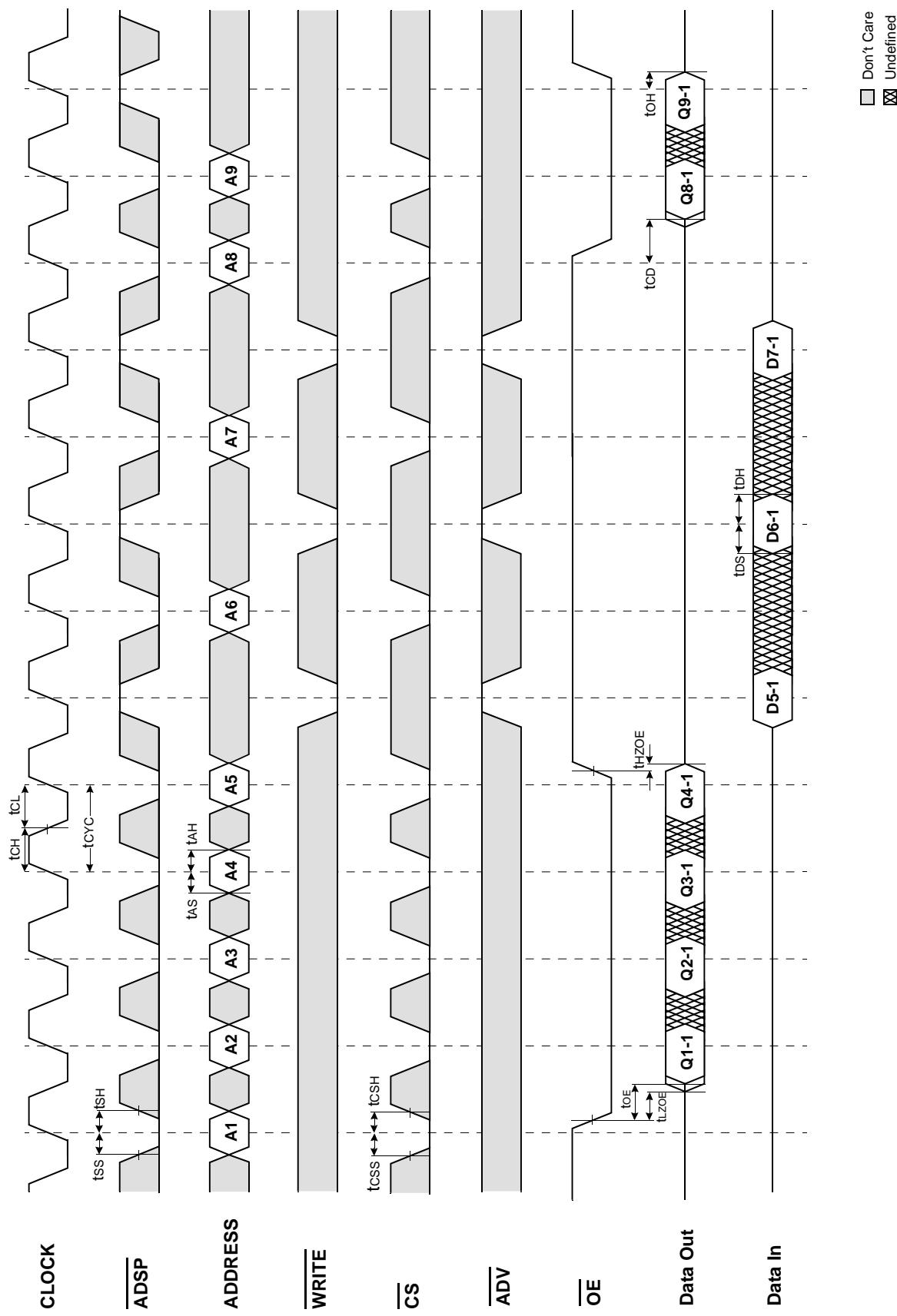


**TIMING WAVEFORM OF COMBINATION READ/WRTE CYCLE( $\overline{ADSP}$  CONTROLLED,  $\overline{ADSP} = \text{HIGH}$ )**

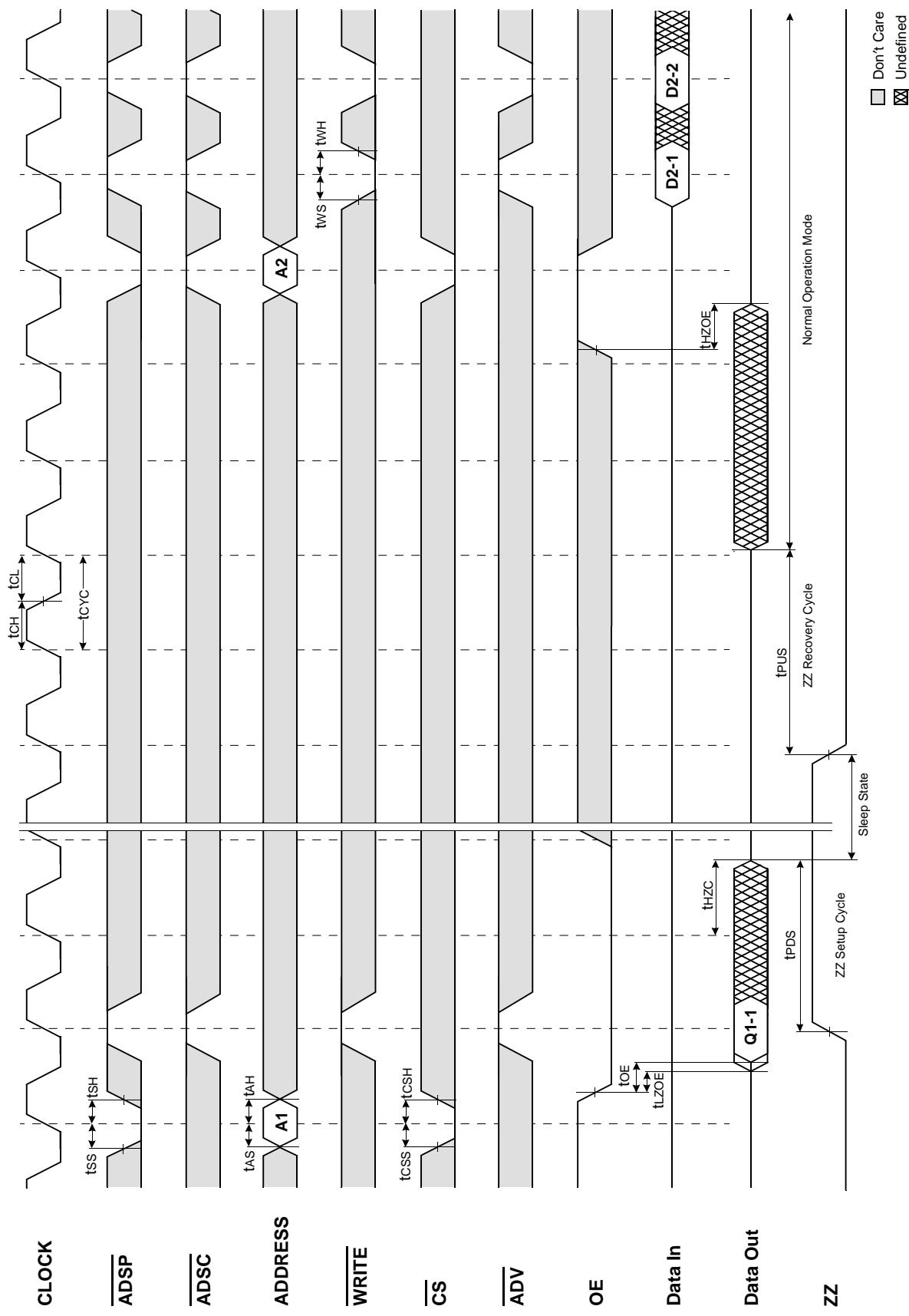
## TIMING WAVEFORM OF SINGLE READ/WRITE CYCLE(ADSC CONTROLLED, ADSP=HIGH)



## TIMING WAVEFORM OF SINGLE READ/WRITE CYCLE(ADSP CONTROLLED, ADSC=HIGH)

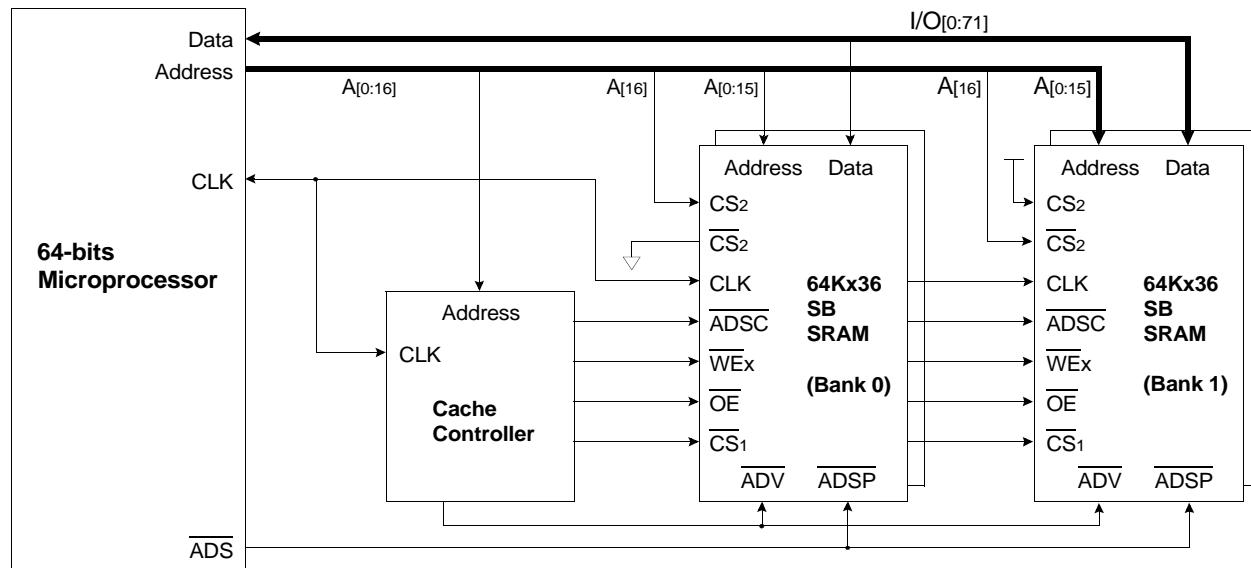


## TIMING WAVEFORM OF POWER DOWN CYCLE

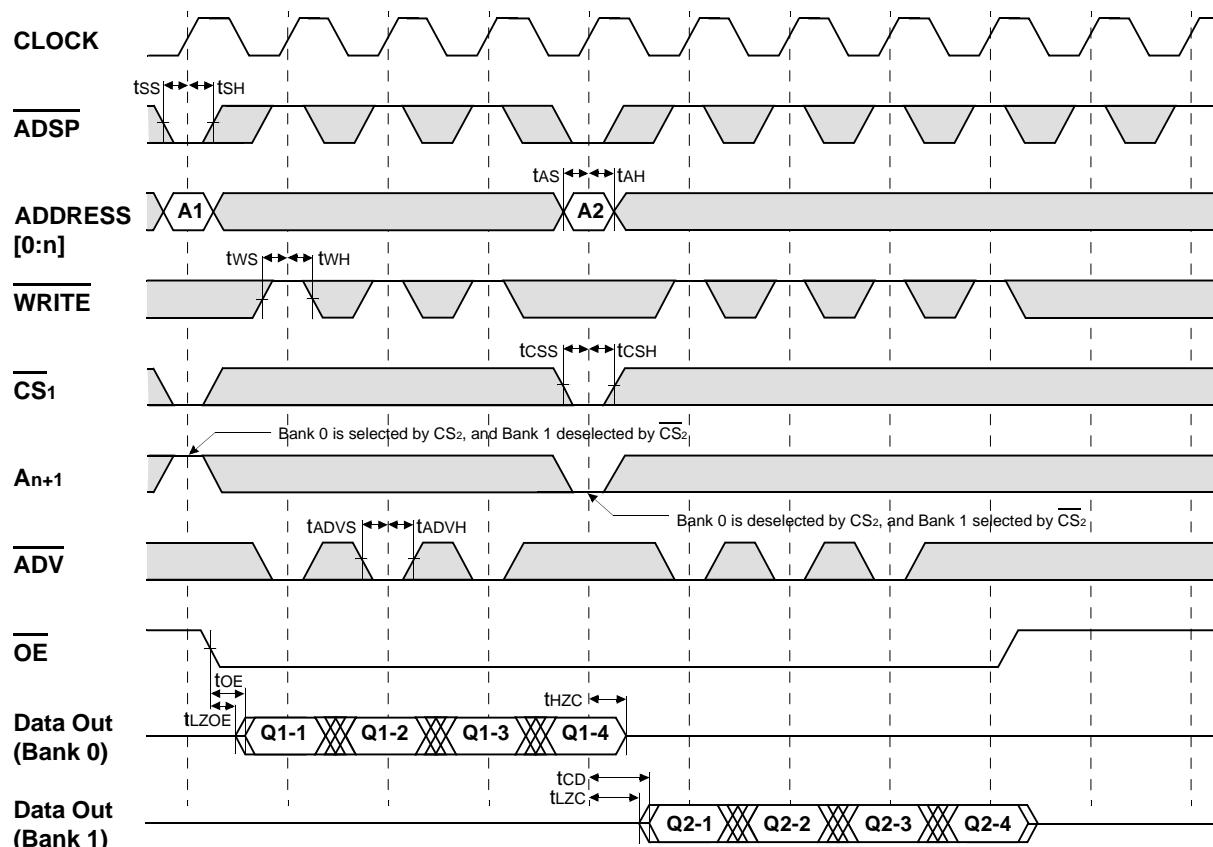


**APPLICATION INFORMATION****DEPTH EXPANSION**

The Samsung 64Kx36 Synchronous Burst SRAM has two additional chip selects for simple depth expansion. This permits easy secondary cache upgrades from 64K depth to 128K depth without extra logic.

**INTERLEAVE READ TIMING** (Refer to non-interleave write timing for interleave write timing)

(ADSP CONTROLLED , ADSC=HIGH)



\*NOTES n = 14 32K depth, 15 64K depth, 16 128K depth

□ Don't Care    X Undefined

## PACKAGE DIMENSIONS

100-TQFP-1420A

Units: millimeters/inches

